

<b>Notice of References Cited</b>	Application/Control No. 10/790,144		Applicant(s)/Patent Under Reexamination IKEZOE, MICHINORI	
	Examiner Hau V. Phan		Art Unit 3618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,368,748	04-2002	Takee et al.	429/223
*	B	US-6,920,948	07-2005	Sugiura et al.	180/65.2
*	C	US-6,615,118	09-2003	Kumar, Ajith Kuttannair	701/19
*	D	US-6,158,537	12-2000	Nonobe, Yasuhiro	180/65.3
*	E	US-6,166,934	12-2000	Kajouke et al.	363/65
*	F	US-6,447,969	09-2002	Ito et al.	430/106.3
*	G	US-6,255,008	07-2001	Iwase, Masayoshi	429/9
*	H	US-2003/0129459	07-2003	Ovshinsky et al.	429/9
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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